

# Alternator Diode (Super Low Loss type)

## Type code : MSM35J22 / MSM35J22R

■1. Absolute maximum ratings (Unless otherwise stated, Ta=25°C)

No.	Item	Symbol	Units	Min.	Typ.	Max.	Conditions
1	Operating junction temperature	Tj	°C	-40	-	175	
2	Minimum Operating voltage	Vo	V	8	-	-	
3	Operating frequency	fo	Hz	50	-	3,000	
4	Average rectified forward current	IF(Av)	A	-	-	35	Single-phase half sine wave 50% duty
5	Storage Temperature	Tstg	°C	-40	25	175	Stored at not applied voltage
6	Forward Surge Capability	IFSM	A	530	-	-	T=10±1ms Non-Repetitive Sine Wave*1
7	Reverse Surge Capability	VRSM	V	58	-	-	Refer to followings.*2

■Absolute maximum ratings test conditions

No.6: Forward Surge test\*1

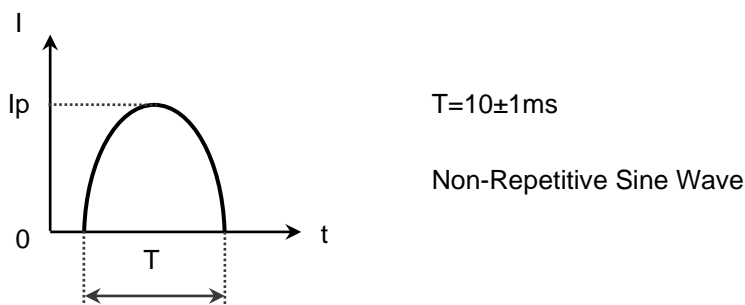


Fig 1-1. Forward Surge test sequence

No.7: Reverse Surge \*2

Measuring Circuit

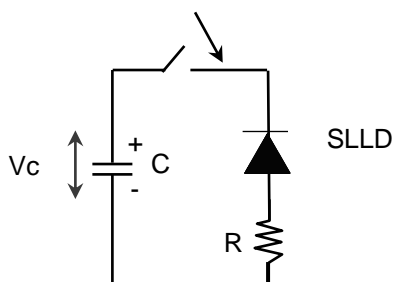


Fig 1-2. Reverse Surge testing circuit

Applied Voltage waveform

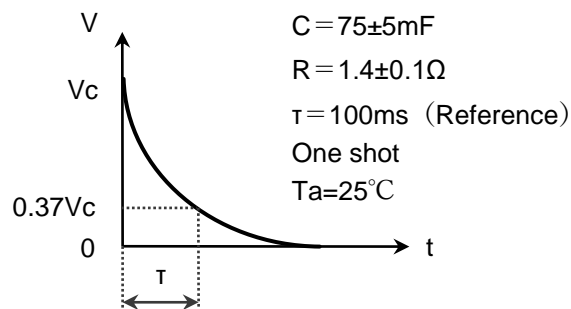
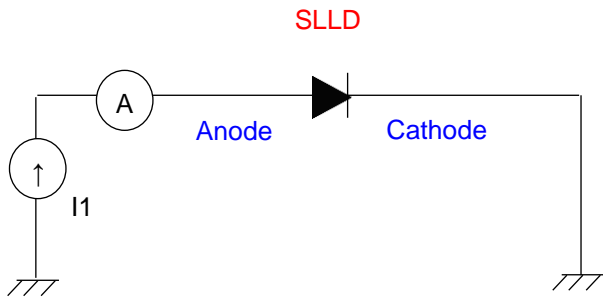


Fig 1-3. Reverse Surge test sequence

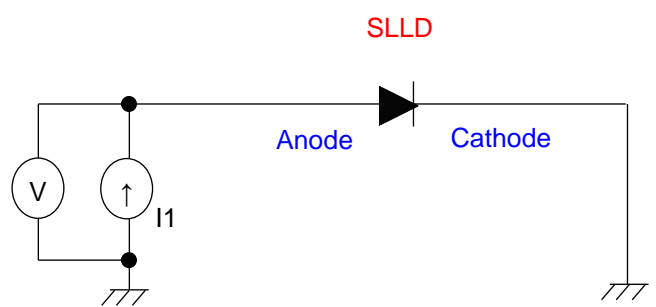
■2. Electrical characteristics(Ta=25°C)

No.	Item	Symbol	Units	Min.	Typ.	Max.	Conditions (Refer to below fig.)
1	Leakage current .	IR	μA	-	-	0.8	VR=18V
2	Zener voltage	Vz	V	20	-	24	Iz=10mA
3	Active mode forward voltage	VF(35A)	V	-	-	0.105	IF=35A,t=5ms
4	Active mode forward voltage	VF(100A)	V	-	-	0.3	IF=100A,t=5ms



I1 Power supplier : 18V/2mA

Fig 2-1. IR testing circuit



I1 Power supplier : 10mA/100V (Vz measurement)

35A or 100A/15V (VF measurement)

Fig 2-2. Vz and VF testing circuit

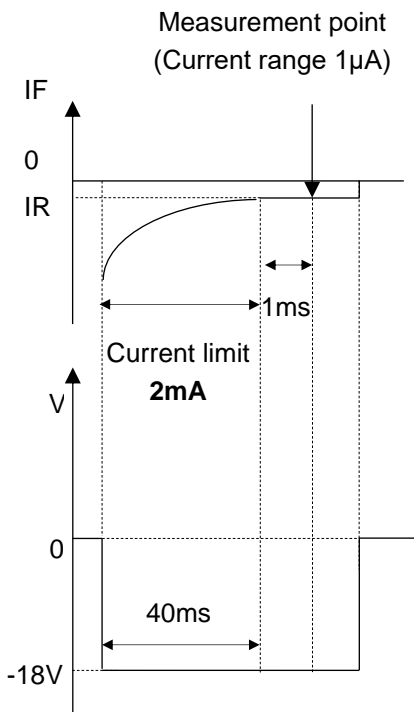


Fig 2-3. IR testing sequence

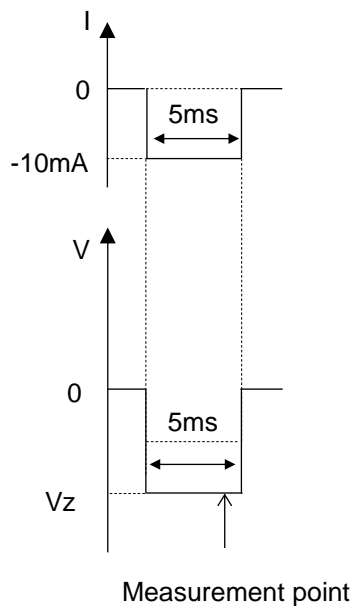


Fig 2-4. Vz testing sequence

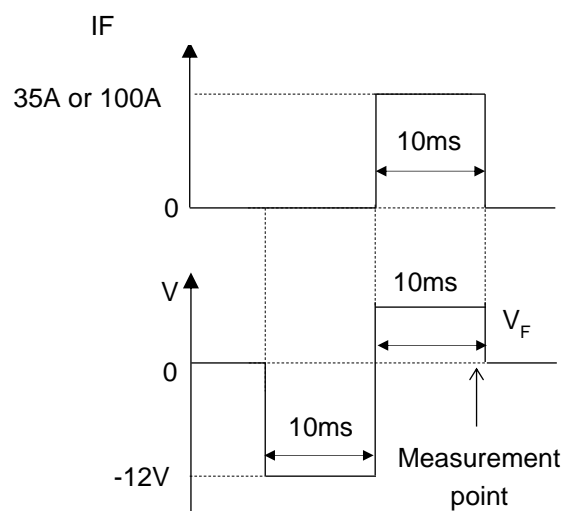


Fig 2-5. VF testing sequence

We recommend measuring in the order of IR,VZ ,VF.

### ■3. Mechanical, reliability characteristics (Ta=25°C)

No.	Item	Units	Min.	Typ.	Max.	Conditions
1	Press in force	kN	1.5	-	12	<a href="#">Refer to chapter 8 for detail*3</a>
2	Lead bending	mm	-	-	5	Bend 3 times from side to side. Refer to <a href="#">Fig.3-1</a>
3	Lead pulling	N	150	-	-	Refer to <a href="#">Fig3-2</a>

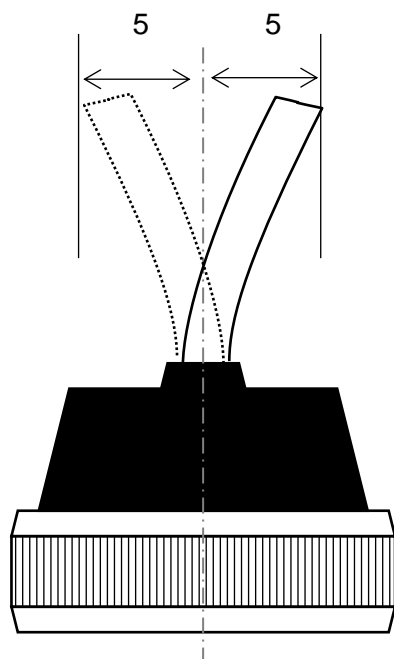


Fig 3-1. Lead bending

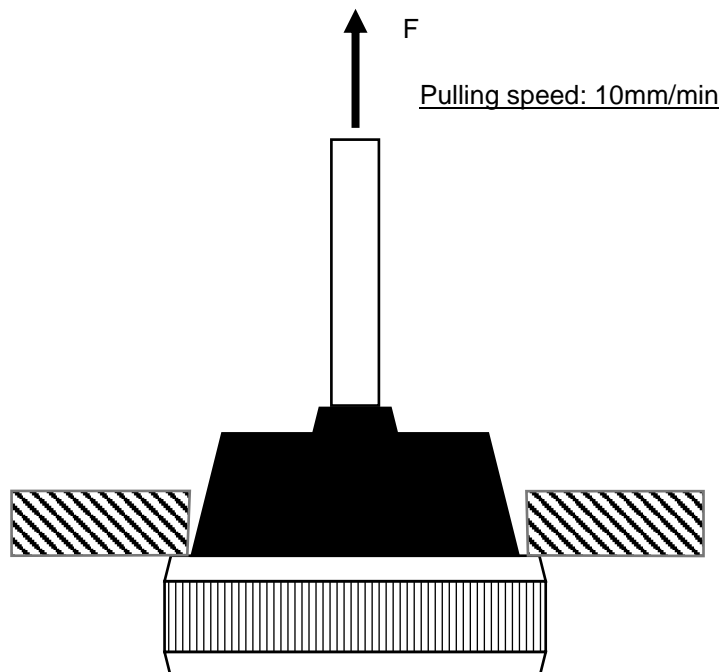


Fig 3-2. Lead pulling

### ■4. Reliability test

No.	Item	Sample	Test conditions	Criteria
1	Thermal fatigue test	11 pair	IF=35A, Tj=50°C⇔175°C, Refer to Appendix B and <a href="#">FigB-1</a> .	B(10) ≥ 3,400 B(50) ≥ 7,200
2	High Temperature Blocking	5 pair	Tc=175°C, V=11±2Vrms, 60Hz or 50Hz	1000hr
3	High Temperature and High Humidity Blocking	5 pair	Tc=80°C±5°C, RH=90%±5%, V=11±2Vrms, 60Hz or 50Hz	1000hr
4	Thermal Shock	11 pair	Tc=-40°C±5°C⇔175°C±5°C Time to raise, lower and keep temperature 15min.±5min. each	500cycle
5	Water Immersion	5 pair	95°C±5°C (Water) ⇔ 25°C±5°C (Water) 10±1min within 10sec., 10±1min.	100 cycles
6	Oil Immersion	5 pair	133±5°C(Oil) ⇔ R.T.(Air) 10±1sec. ⇔ 60±10min. Oil:ASTM#1, IRM903, or Equivalent	50cycle
7	Gasoline Immersion	5 pair	25±5°C(Gasoline) ⇔ R.T.(Air) 10±1sec. ⇔ 60±10min. Gasoline: Gasoline for General Vehicle	50cycle
8	Anti-freezing Fluid Immersion	5 pair	95±5°C(Anti-freezing Fluid) ⇔ R.T.(Air) 10±1sec. ⇔ 60±10min. Composition of Anti-freezing Fluid :Ethylene Glycol 50%, Water 50%	50cycle
9	Wash Fluid Immersion	5 pair	50±5°C(Wash Fluid) ⇔ R.T.(Air) 10±1sec. ⇔ 60±10min. Composition of Wash Fluid: 5±1%Lypon F(Trade name) or Equivalent	50cycle

10	Salt Spray test	5 pair	Test procedure follows JIS Z 2371.	Test procedure follows JIS Z2371.
11	High operating life	11 pair	Ta=175°C, V=18±1Vrms, 3000Hz, R=1±0.1Ω,	1000hr
12	Temperature Humidity-Bias	11 pair	Ta=85±2°C, RH=85±5%, V=18±1Vrms, 3000Hz, R=1±0.1Ω,	1000hr
13	USPCBT	11 pair	Ta=120±2°C, RH=85±5%, Steam Pressure 1.7×10 <sup>5</sup> Pa V=18±1Vrms, 3000Hz, R=1±0.1Ω,	96Hr
14	PCT	11pair	Ta=121°C, RH=100%, Steam Pressure 2.03×10 <sup>5</sup> Pa	96hr
15	ESD tolerance	11pair	1)R=2kΩ, C=330pF, Discharge: Contact, Air 2)R=300Ω, C=330pF, Discharge: Contact, Air Test procedure follows ISO10605.	V=±15kV Test procedure follows ISO10605.

■5. Part dimensions

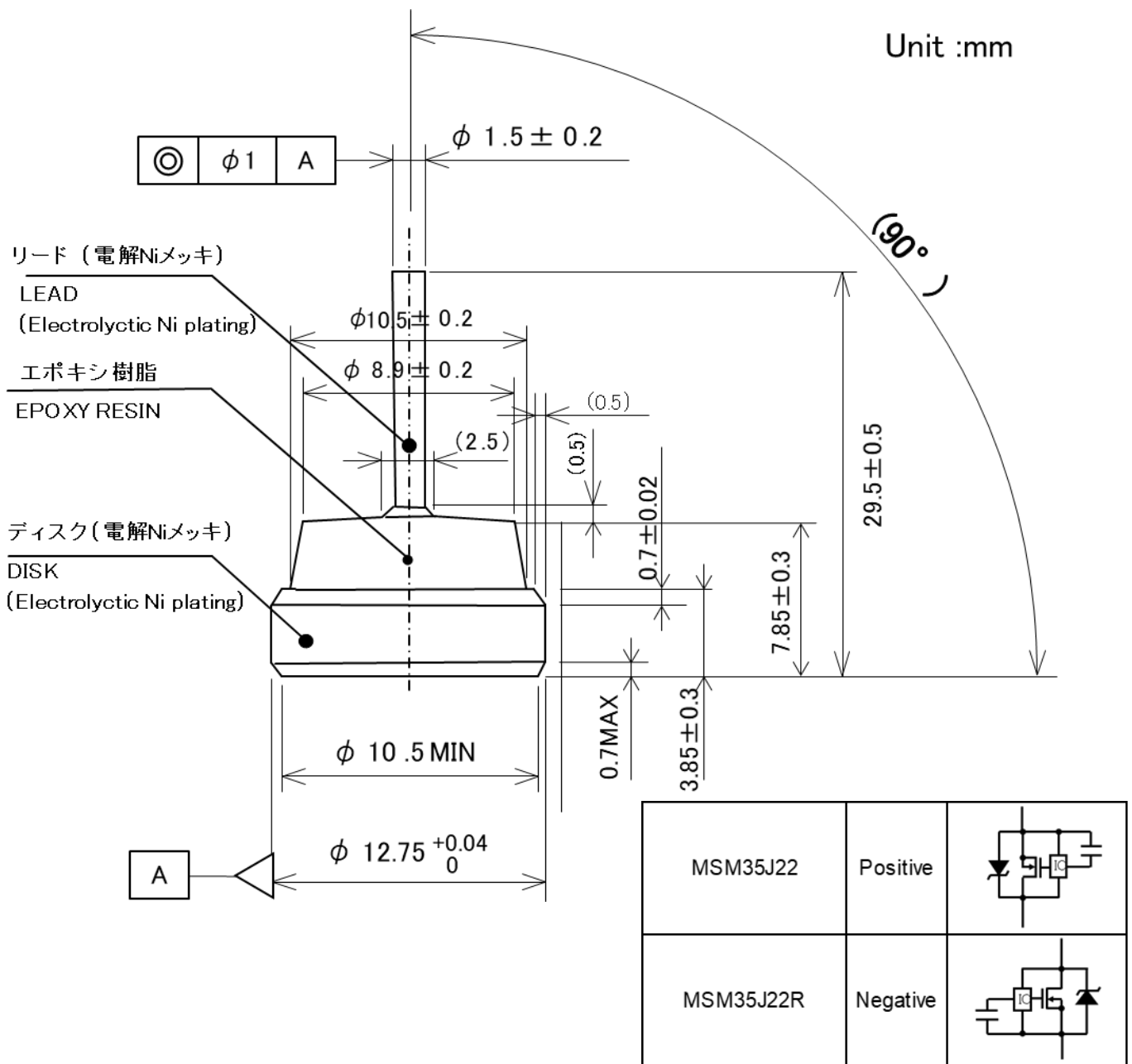


Fig 5. Physical Dimensions

■6. Marking

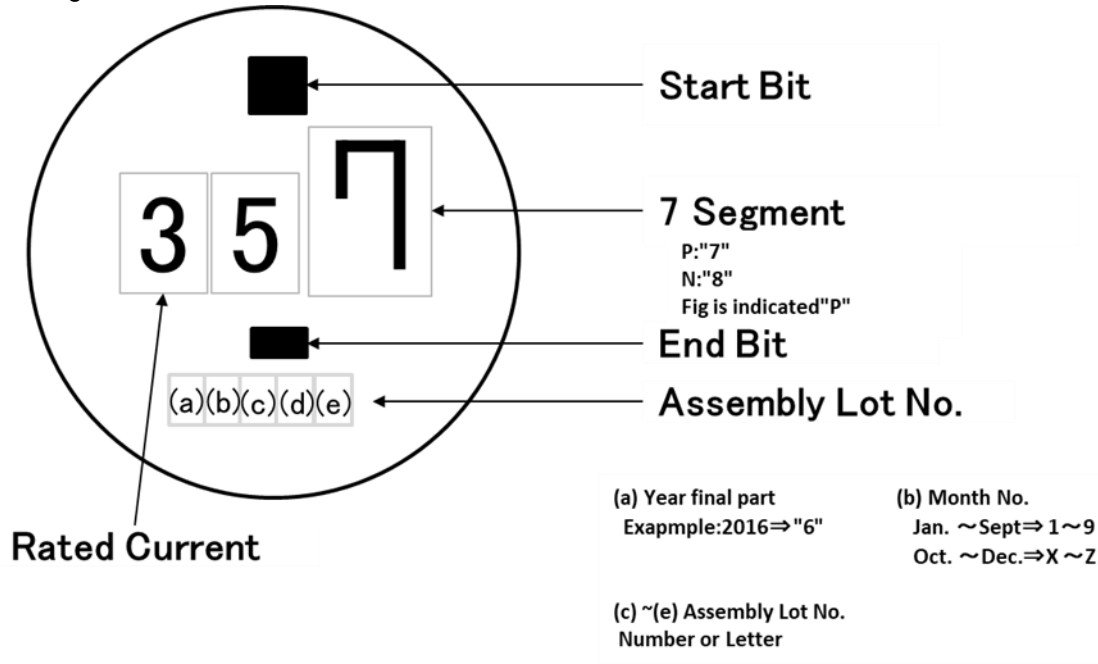


Fig6. Marking diagram

■7. Packing

1.Packing quantity : 32,400pcs

1)Cardboard box size : W 150mm x L 220mm x H 75mm  
Quantity : Diode 450 pcs/Cardboard box x Cardboard box 72 boxes  
Baseplate size: W 145 mm x L 214 mm x t 5 mm  
2)Air packing size:W 440mmx L 600 mm  
3)Array of cardboard: 4 rows x 3 rows x 6 steps(=72 Boxes)  
4)Label (Example) : Address, Type, Parts No., SUPPLIER, Quantity, Items

SLLD (Address)	
Type	MSM35J22
Name	SLLD35A (+)
Parts number	
Quantity	450pcs
Notes	

2.Packing method :

1)We assemble a reinforced cardboard box.  
2)We pack the inner cardboard boxes into a Polyethylene bag in the reinforced cardboard box.  
3)After the lid of the reinforced cardboard box is stopped by the tape, the box is fixed to the palette by PP-band

3.Plywood box;  
Box size : W 528 mm x L 955 mm x H 623 mm

1)Label example

SLLD (Address)	
Type	MSM35J22
Name	SLLD35A (+)
Parts number	
Quantity	32400pcs
Notes	

Fig7. Packing specification

■8.Notcies on the use of products \*3

1) Precautions for handling during press-fitting

Based on the following standards, we guarantee the press-fit condition according to the results of the evaluation. Regarding detail validation, please refer to [Appendix.C](#) .

The fin (heatsinks) design and press-fit conditions of the fins (heatsinks) should be determined based on this standard. If you deviate from this regulation, there is a possibility that the press-fit conditions may not be able to guarantee, so please contact us in advance.

**A) Standard Fin and caution for design**

The fins should be designed with the material, dimension described in [table 8-1](#).

In addition, be sure to chamfer the press-fit hole. The recommended value for the Chamfer is C0.5.

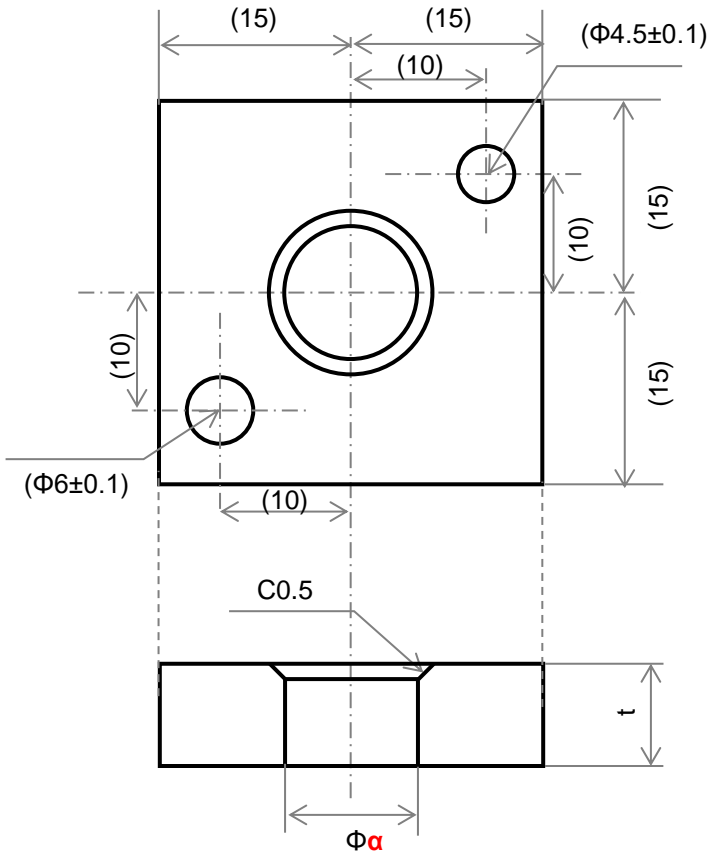


Fig 8-1. FIN outline (unit in mm)

Table.8-1, Standard Fin specification

Material	Thickness t(mm)	Hole size φα(mm)
A5052R-H34	4±0.1	12.625±0.025
ADC12	4±0.1	12.645±0.005

**B) Standard press-fit pin(jig)**

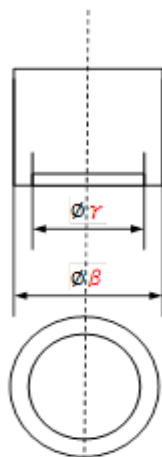


Table.8-2,Standard Press-fit pin

Material	SK105
Press-fit pin outer diameter φβ(mm)	12.2±0.2
Press-fit pin inner diameter φγ(mm)	7±0.05

Fig.8-2 Press-fit pin outline

### C) Press-fit methods and cautions

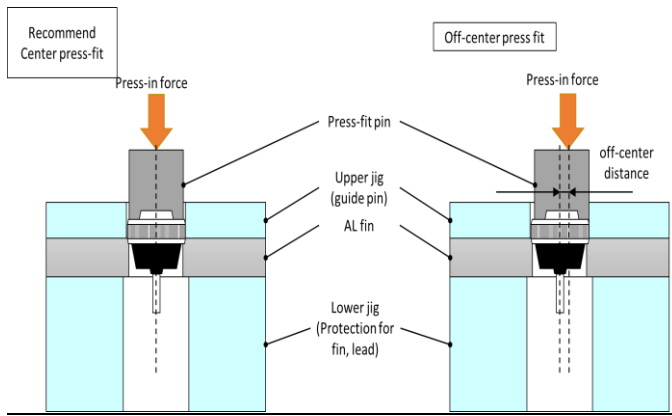


Fig.8-3 Press-fit method

Table.8-3.Press-fit condition

Item	Min	Typ	Max
Press-fit speed (mm/sec)	1	-	5
Off-center distance(mm)	0	0	1.5
Press-fit Depth(mm)	-	-	4
Press-in force (A5052R-H34)	1.5	-	12
Press-in force (ADC12)	1.5	-	12

- ① Consider the position accuracy of fins, pins, and products so as not to misalignment when press-in. (Refer to Fig8-3)
- ② We recommend providing a guide with the upper jig to press fit the product vertically rather than diagonally.
- ③ We recommend providing a lower receiving jig to prevent deformation of the fins during press fitting.
- ④ Monitor the press-in force and perform process control such as rejecting possible products that are greatly out of the normal distribution.
- ⑤ Pushing the bottom of disk locally will cause characteristic degradation or destruction of the product.
- ⑥ When press-fitting, be careful not to get foreign objects between the press-fitting jig and the bottom of the disk.

#### 2) Cautions on lead handling

When corrected the lead bending etc., correct the vertical width of 5mm from the lead tip only once, as shown in Fig.5-4. In addition, the lead should be fixed vertically with terminal block, etc., without stresses such as tension and compression are not applied.

#### 3) Cautions on lead welding

- ① If it is necessary to bend lead at welding, please follow [section 2](#) above in this chapter.
- ② If it is necessary to change lead length, you can use by cutting the leads.
- ③ Regarding lead terminal connections, we recommend the TIG welding. Due to terminal material, welding method or assembling conditions, it may cause the degradation or destruction of device.
- ④ Therefore, the processing and welding conditions of the lead should be used after a sufficient pre-evaluation by the customer and the Reliability test after the implementation.

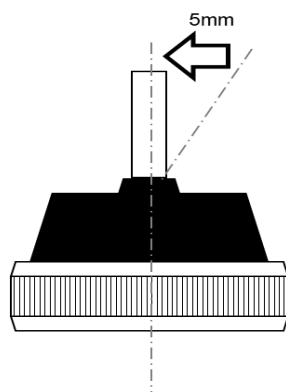


Fig.5-4 Lead bend correction

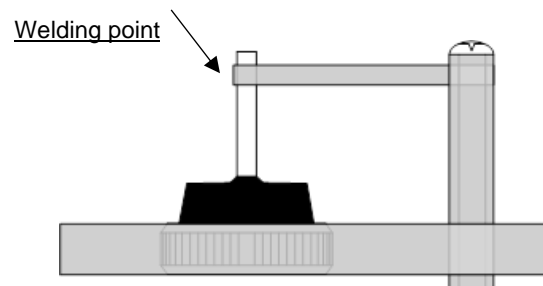


Fig.5-5 Lead Terminal welding

**■9. Caution for Storage**

- 1) The products should be stored at a temperature of less 35°C and relative humidity of less than 60% away from direct sunlight and moisture. Upon storage, keep them polyethylene bags until for use, and they should be used within 12 months.
- 2) The Storage room should not contain any corrosive gas (e.g., sulfurous acid gas and chlorine gas)
- 3) When stored for a long time after unpacked, it must be stored at a temperature of less 35°C and relative humidity of less than 60% and free from corrosive gas. Such products should be used within 30 days of unpacking.
- 4) If the storage is not appropriate, the weldability of the lead material may be regraded.

**■10. Safety precautions**

The handling precautions of this product are shown below. Failure to comply with this precaution may result in human or property damage caused by personal accidents, fire accidents, etc.

- 1) Regardless of changes in external conditions during use “absolute maximum ratings” should never be exceeded in designing electronic circuits that employ semiconductors.  
In no event shall Hitachi be liable for any failure in a semiconductor device or any secondary damage resulting from use at a value exceeding the absolute maximum rating.  
When using, please use it with sufficient derating in consideration.
- 2) Semiconductor devices may experience failures due to accidental or unexpected surge voltage, current, etc. Accordingly, adopt safe design features, such as redundancy or prevention of malfunctions, to avoid extensive damage in the event of a failure.
- 3) If this product fails, there may be cases in which the semiconductor device, wiring or wiring pattern will emit smoke or cause a fire.
- 4) We strongly recommend measuring electrical characteristics in incoming inspection and post-assembly inspection.



**【Usage】**

- (1) HPSD warrants that the HPSD products have the specified performance according to the respective specifications at the time of its sale. Testing and other quality control techniques of the HPSD products by HPSD are utilized to the extent HPSD needs to meet the specifications described in this document. Not every device of the HPSD products is specifically tested on all parameters, except those mandated by relevant laws and/or regulations.
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■Appendix

A)Rating and Characteristic Curves

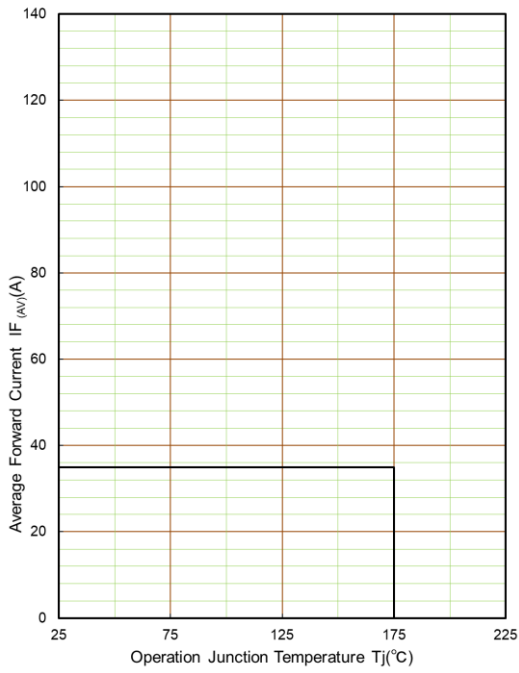


Fig.A-1 Power Dissipation Curves

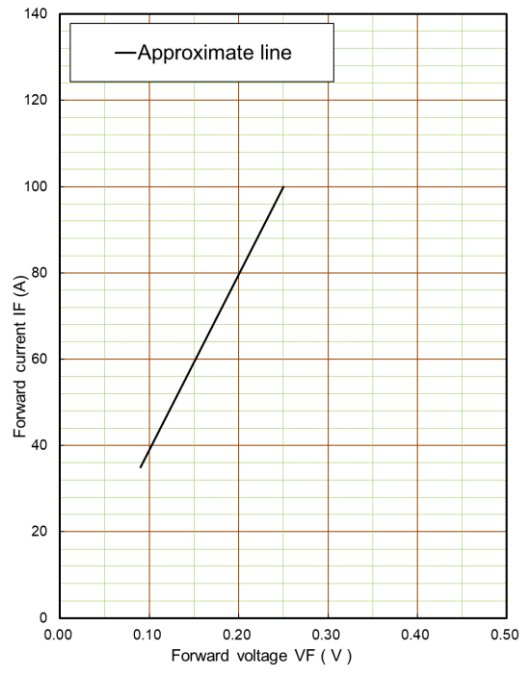


Fig.A-2 Forward current – Forward voltage\*

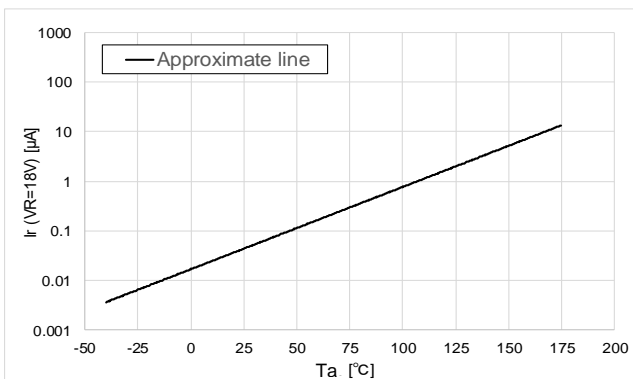


Fig.A-3. Leakage current – Temperature \*a

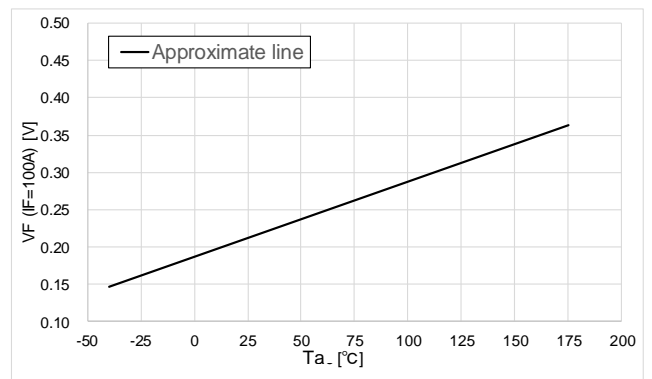


Fig.A-4. Forward voltage – Temperature \*

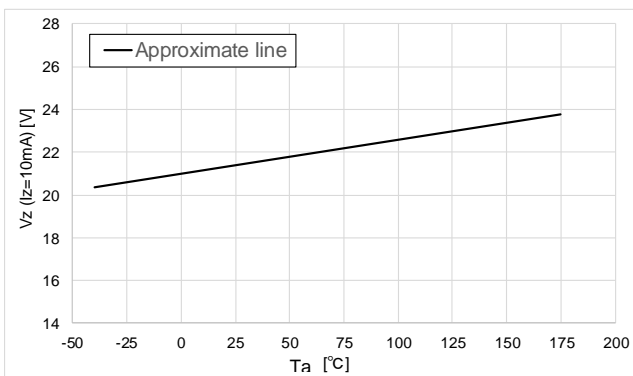


Fig.A-5. Zener voltage – Temperature \*

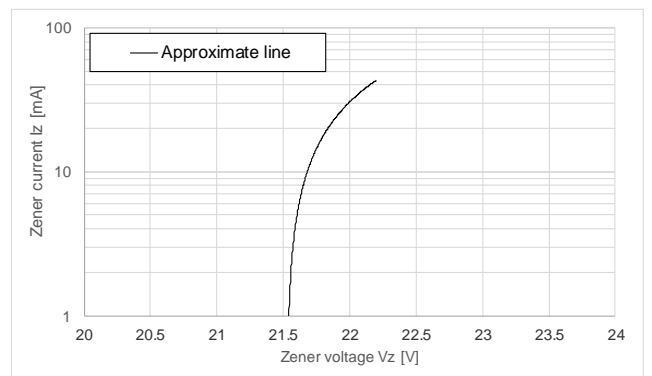
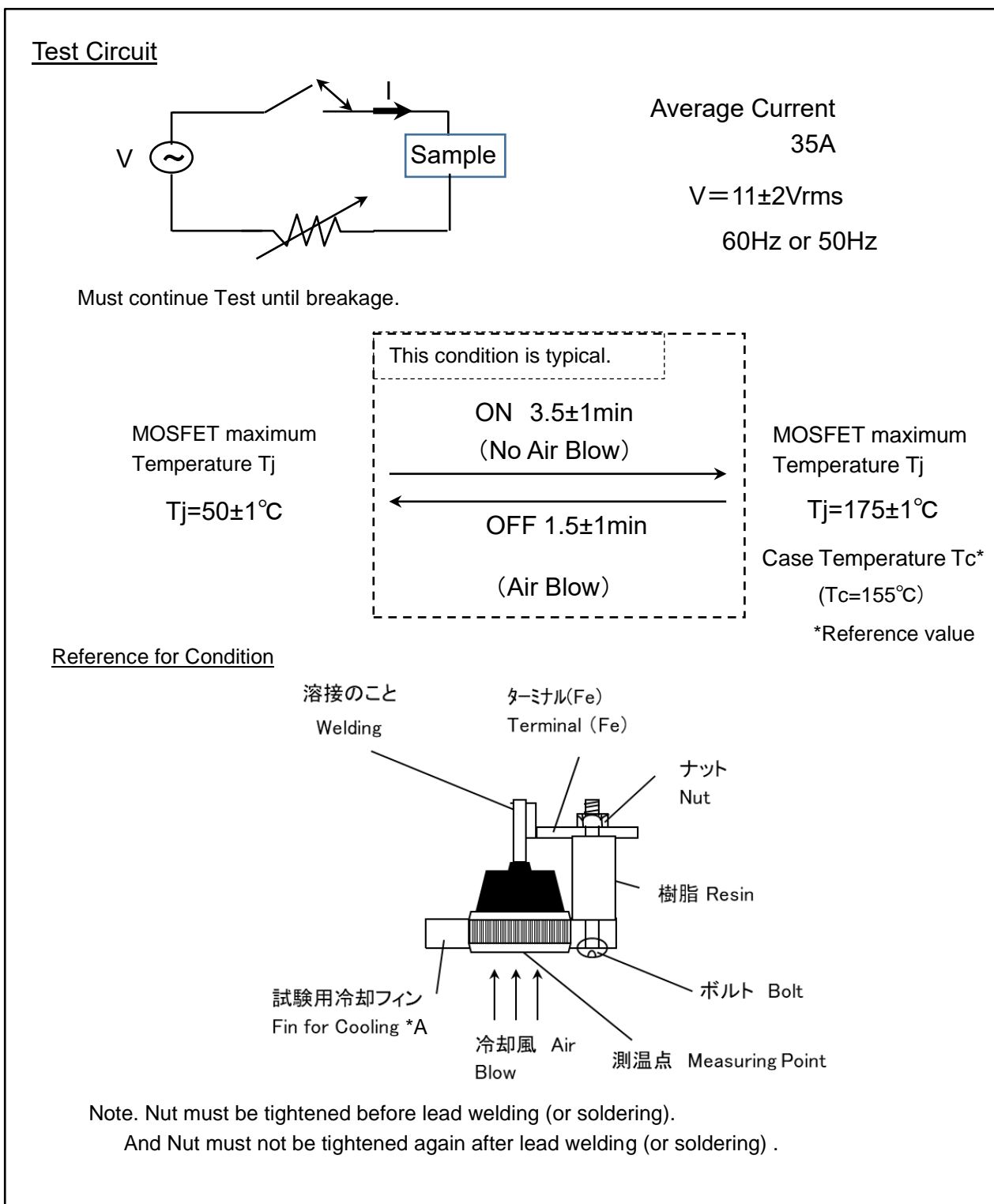


Fig.A-6. Zener current – Zener voltage \*

\*Fig.A-2 to A-6 are shown for reference only and are approximated from the measured data.

B)TFT conditions



\*A The fin conditions are basically same as [Fig.8-1](#), but when ON-OFF Timing does not meet TFT Test Specification, Fin Shape can be changed only used TFT Test.

Fig.B-1 Thermal Fatigue Test (TFT)

C) Pres-in force and Strain

In order to prevent the destruction, and decrease of electrical characteristics of the product under the load at the time of press-fit, we recommend to validate the strain on the bottom of the disk during press-fit. An example of our validation is shown in below. Please contact us for detailed validation methods.

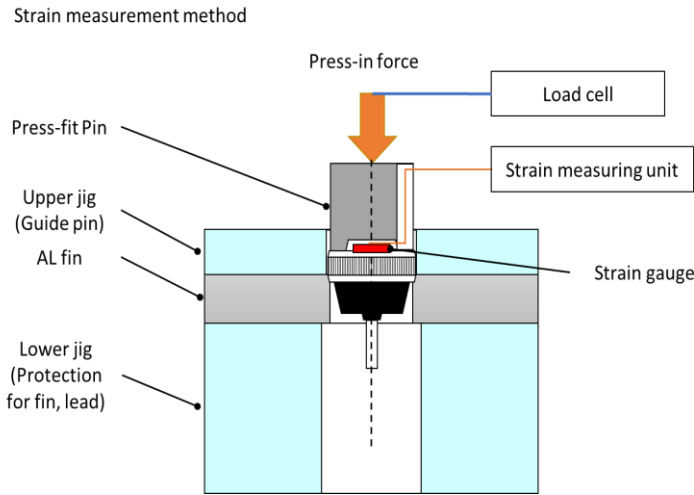


Fig.C-1 Jig and strain-measurement point

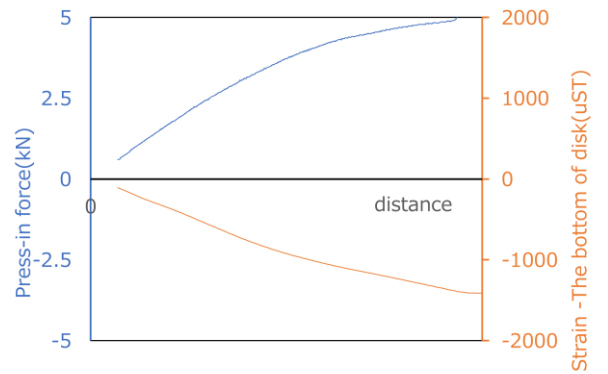


Fig.C-2 Example of strain and press-in force measurement

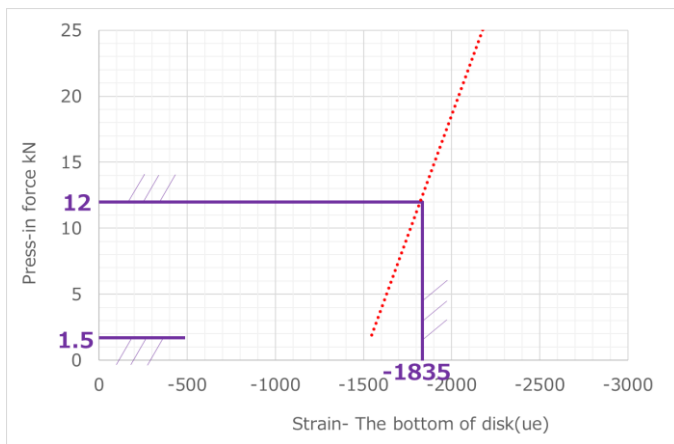


Fig.C-3 Example of strain and press-in force validation  
 Measure by changing the interference,  
 Strain threshold is calculated from analysis results